Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/612,011	JENTSCH ET AL.
Examiner	Art Unit
Hoang-Vu A. Nguyen-Ba	2192

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Date	Examiner
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Inventor name Search	4/20/2006	HAN	
East Search (USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM-TDB) See Search History Printout	4/20/2006	HAN	
717/124-135; 712/226-227, 244; 714/34-35, 38 - text search only	4/20/2006	HAN	
			